BUK794R1-40BT

N-channel TrenchPLUS standard level FET

Rev. 02 — 16 February 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using NXP High-Performance Automotive (HPA) TrenchMOS technology. The devices include TrenchPLUS diodes for temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Allows responsive temperature monitoring due to integrated temperature sensor
- Low conduction losses due to low on-state resistance
- Q101 compliant
- Suitable for thermally demanding environments due to 175 °C rating

1.3 Applications

- 12 V loads
- Electrical Power Assisted Steering (EPAS)
- General purpose power switching
- Motors, lamps and solenoids

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	-	40	V
I _D	drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C};$ see <u>Figure 2</u> ; see <u>Figure 3</u> ;	[1]	-	-	75	Α
		$V_{GS} = 10 \text{ V}; T_{mb} = 100 \text{ °C};$ see <u>Figure 2</u> ;	[1]	-	-	75	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>		-	-	272	W
Static ch	aracteristics						
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 7}}{\text{Figure 8}}; \text{ see } \frac{\text{Figure 8}}{\text{Figure 8}}$		-	3.4	4.1	mΩ

^[1] Continuous current is limited by package.



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		d a
2	Α	anode	mb	
3	D	drain		
4	K	cathode		g ()
5	S	source		\
mb	D	mounting base; connected to drain	1 2 3 4 5 SOT263B (TO-220)	03nm72 s k

3. Ordering information

Table 3. Ordering information

Type number	Package	Package					
	Name	Description	Version				
BUK794R1-40BT	TO-220	plastic single-ended package; heatsink mounted; 1 mounting hole; 5-lead TO-220	SOT263B				

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	40	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	40	V
V_{GS}	gate-source voltage			-20	20	V
I _D drain current	drain current	$T_{mb} = 25 ^{\circ}\text{C}; V_{GS} = 10 \text{V}; \text{see } \frac{\text{Figure 2}}{\text{Figure 2}};$	[1]	-	187	Α
		see <u>Figure 3</u> ;	[2]	-	75	Α
		T_{mb} = 100 °C; V_{GS} = 10 V; see <u>Figure 2</u> ;	[2]	-	75	Α
I_{DM}	peak drain current	T_{mb} = 25 °C; $t_p \le 10 \mu s$; pulsed; see <u>Figure 3</u>		-	748	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>		-	272	W
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-dr	ain diode					
Is	source current	$T_{mb} = 25 ^{\circ}C;$	[1]	-	187	Α
			[2]	-	75	Α
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	748	Α
Avalanche	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 75 A; $V_{sup} \le 40$ V; R_{GS} = 50 Ω ; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped		-	1.5	J
Electrosta	tic discharge					
V _{esd}	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 kΩ		-	4	kV

^[1] Current is limited by power dissipation chip rating.

^[2] Continuous current is limited by package.

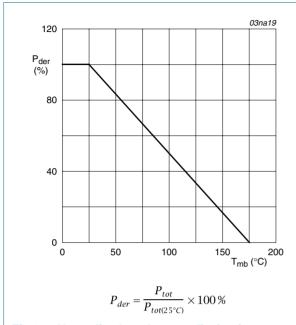


Fig 1. Normalized total power dissipation as a function of mounting base temperature

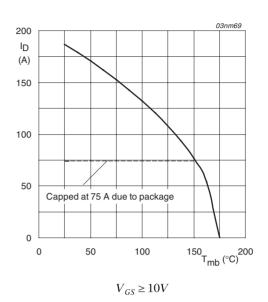
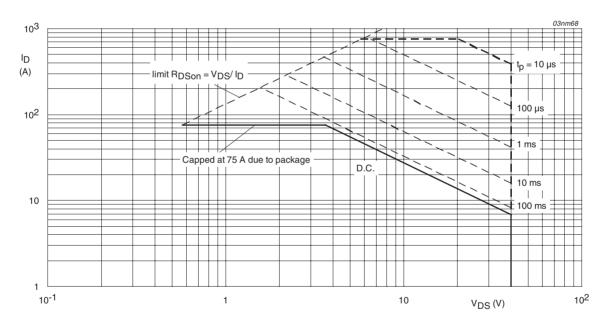


Fig 2. Continuous drain current as a function of mounting base temperature



 $T_{mb} = 25$ °C; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in still air	-	-	60	K/W
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	0.55	K/W

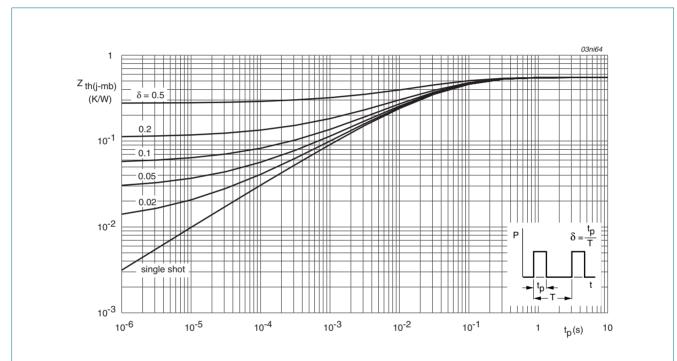


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
_		Conditions	IVIIII	тур	IVIAX	Offic
	aracteristics	1 005 AV 0V T 0500	40			
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	40	-	-	V
	-	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	36	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 25 \text{ °C}$; see Figure 9	2	3	4	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 175 \text{ °C}$; see <u>Figure 9</u>	1	-	-	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see Figure 9	-	-	4.4	V
I _{DSS}	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	1	μΑ
		V _{DS} = 40 V; V _{GS} = 0 V; T _i = 175 °C	-	-	500	μΑ
I_{GSS}	gate leakage current	V _{DS} = 0 V; V _{GS} = 20 V; T _j = 25 °C	-	2	100	nA
		V _{DS} = 0 V; V _{GS} = -20 V; T _j = 25 °C	-	2	100	nA
R _{DSon} drain-source on-state resistance		V_{GS} = 10 V; I_D = 50 A; T_j = 25 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	-	3.4	4.1	mΩ
		V_{GS} = 10 V; I_D = 50 A; T_j = 175 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	7.8	mΩ
V _{F(TSD)}	temperature sense diode forward voltage	$I_F = 1 \text{ mA}; T_j = 25 \text{ °C}$	1.58	1.6	1.63	V
S _{F(TSD)}	temperature sense diode temperature coefficient	$I_F = 1 \text{ mA}; T_j > 55 \text{ °C}; T_j < 175 \text{ °C}$	-2.55	-2.83	-3.11	mV/K
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}$; $V_{DS} = 32 \text{ V}$; $V_{GS} = 10 \text{ V}$;	-	83	-	nC
Q_{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 14</u>	-	18	-	nC
Q_{GD}	gate-drain charge		-	29	-	nC
Ciss	input capacitance	V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz;	-	5106	6808	pF
Coss	output capacitance	T _j = 25 °C; see <u>Figure 12</u>	-	1389	1667	pF
C _{rss}	reverse transfer capacitance		-	527	721	pF
d(on)	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V};$	-	38	-	ns
r	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C$	-	82	-	ns
d(off)	turn-off delay time		-	141	-	ns
if	fall time		-	90	-	ns
-D	internal drain inductance	from drain lead 6 mm from package to centre of die; T _i = 25 °C	-	4.5	-	nΗ
		from contact screw on mounting base to centre of die; T _i = 25 °C	-	3.5	-	nΗ
L _S	internal source inductance	from source lead to source bond pad; lead length 6 mm; T _i = 25 °C	-	7.5	-	nΗ

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Source-dr	ain diode					
V_{SD}	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 16</u>	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}$; $dI_S/dt = -100 \text{ A/}\mu\text{s}$; $V_{GS} = -10 \text{ V}$;	-	70	-	ns
Q_r	recovered charge	$V_{DS} = 30 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	55	-	nC

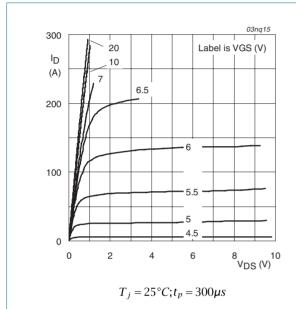


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

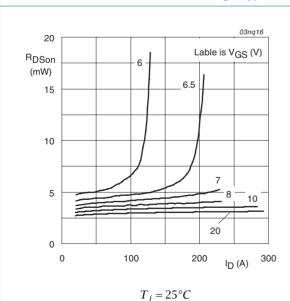


Fig 7. Drain-source on-state resistance as a function of drain current; typical values

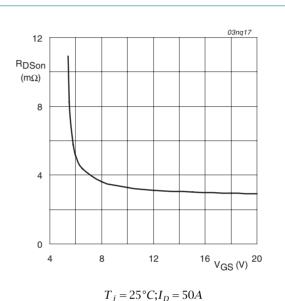
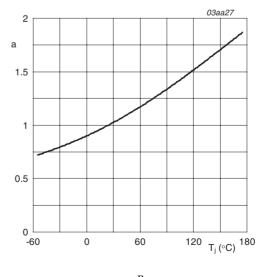
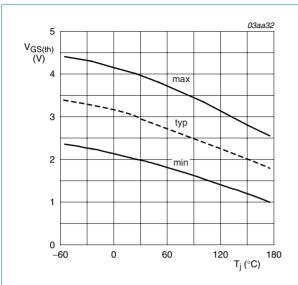


Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values



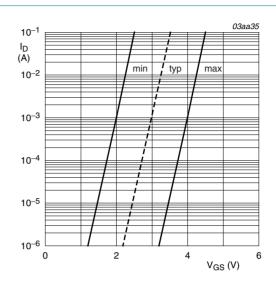
 $a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



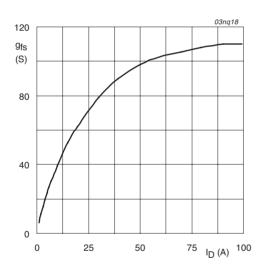
 $I_D = 1 \, mA; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



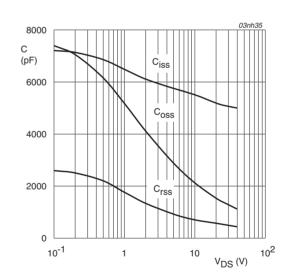
$$T_{j} = 25 \,^{\circ}C; V_{DS} = 5V$$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



 $T_{j} = 25^{\circ}C; V_{DS} = 25V$

Fig 11. Forward transconductance as a function of drain current; typical values



$$V_{GS} = 0V; f = 1MHz$$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

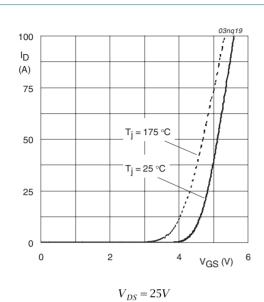
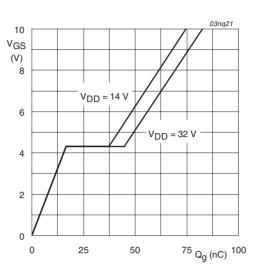


Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values



 $T_i = 25^{\circ}C; I_D = 25A$

Fig 14. Gate-source voltage as a function of turn-on gate charge; typical values

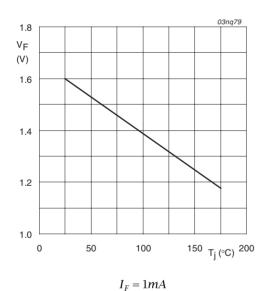


Fig 15. Forward voltage of temperature sense diode as a function of junction temperature; typical values

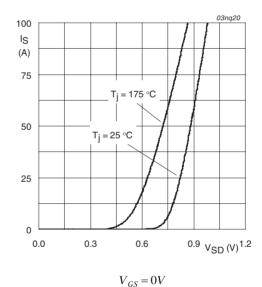
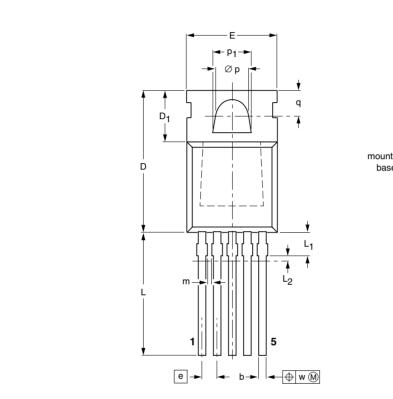


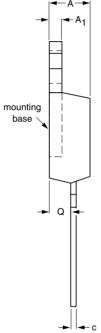
Fig 16. Reverse diode current as a function of reverse diode voltage; typical values

7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 5-lead TO-220

SOT263B





0 5 10 mm

DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	b	С	D	D ₁	E	е	L	L ₁ ⁽¹⁾	L ₂ ⁽²⁾	m	∅p	P ₁	q	Q	w
mm	4.5 4.1	1.39 1.27	0.85 0.70	0.7 0.4	15.8 15.2	6.4 5.9	10.3 9.7	1.7	15.0 13.5	2.4 1.6	0.5	0.8 0.6	3.8 3.6	4.3 4.1	3.0 2.7	2.6 2.2	0.4

Notes

- 1. Terminal dimensions are uncontrolled in this zone.
- 2. Positional accuracy of the terminals is controlled in this zone.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	C JEDEC EIAJ		PROJECTION	ISSUE DATE
SOT263B		5-lead TO-220			01-01-11

Fig 17. Package outline SOT263B (TO-220)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK794R1-40BT_2	20090216	Product data sheet	-	BUK71_794R1_40BT-01
Modifications:	guidelines Legal texts	of this data sheet has be of NXP Semiconductors. have been adapted to the er BUK794R1-40BT sepa	e new company name w	here appropriate.
BUK71_794R1_40BT-01 (9397 750 13954)	20041104	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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BUK794R1-40BT

N-channel TrenchPLUS standard level FET

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